

μ PA2690T1R

COMPLEMENTARY MOSFET 20V, 4.0A, $42m\Omega$ / -20V, -3.0A, $79m\Omega$

R07DS1000EJ0101 Rev.1.01 Mar 04, 2013

Description

The μ PA2690T1R is Dual N- and P-channel MOS Field Effect Transistors for switching application.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

Features

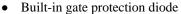
- N-channel 2.5V, P-channel 1.8V drive available
- Low on-state resistance

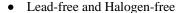
N-channel

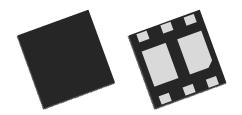
- $R_{DS \text{ (on)1}} = 42 \text{ m}\Omega \text{ MAX}. (V_{GS} = 4.5 \text{ V}, I_D = 2.0 \text{ A})$
- $R_{DS (on)2} = 62 \text{ m}\Omega \text{ MAX}.$ ($V_{GS} = 2.5 \text{ V}, I_D = 2.0 \text{ A}$)

P-channel

- --- R_{DS (on)1} = 79 mΩ MAX. (V_{GS} = -4.5 V, I_D = -1.5 A)
- --- $R_{DS (on)2} = 105 \text{ m}\Omega \text{ MAX}.$ ($V_{GS} = -2.5 \text{ V}, I_D = -1.5 \text{ A}$)
- --- R_{DS (on)3} = 182 mΩ MAX. (V_{GS} = -1.8 V, I_D = -1.5 A)







6pinHUSON2020(Dual)

Ordering Information

Part Number	Package		
μPA2690T1R-E2-AX*1	6pinHUSON2020(Dual)		

Note: *1.Pb-free (This product does not contain Pb in the external electrode and other parts.)

Absolute Maximum Ratings $(T_A = 25^{\circ}C)$

Item	Symbol	N-CHANNEL	P-CHANNEL	Unit
Drain to Source Voltage (V _{GS} = 0 V)	V_{DSS}	20	-20	V
Gate to Source Voltage (V _{DS} = 0 V)	V_{GSS}	±12	∓10	V
Drain Current (DC)	I _{D(DC)}	±4.0	∓3.0	Α
Drain Current (pulse) *1	I _{D(pulse)}	±16	∓12	Α
Total Power Dissipation (1 unit, 5 s) *2	P _{T1}	1	W	
Total Power Dissipation (2 units, 5 s) *2	P _{T2}	2	W	
Channel Temperature	T _{ch}	15	°C	
Storage Temperature	T _{STG}	–55 to	°C	

Notes: *1. PW≤10 μs, Duty Cycle≤1%

*2. Mounted on glass epoxy board of 25.4mm x 25.4mm x 0.8mmt

Caution: This product (N-channel) is electrostatic-sensitive device due to low ESD capability and should be handled with caution for electrostatic discharge.

$$V_{ESD}$$
 = ±400V MIN. (C = 100pF, R = 1.5K Ω)

Electrical Characteristics (T_A = 25°C)

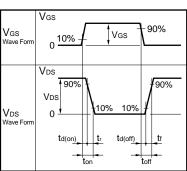
N-channel MOSFET

Characteristics	Symbol	MIN.	TYP.	MAX.	Unit	Test Conditions
Zero Gate Voltage Drain Current	I _{DSS}			1.0	μA	V _{DS} = 20 V, V _{GS} = 0 V
Gate Leakage Current	I _{GSS}			±10	μA	$V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$
Gate Cut-off Voltage	V _{GS(off)}	0.5		1.5	V	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$
Forward Transfer Admittance *1	y _{fs}	5.0			S	$V_{DS} = 10 \text{ V}, I_{D} = 2.0 \text{ A}$
Drain to Source On-state	R _{DS(on)1}		33	42	mΩ	V_{GS} = 4.5 V, I_{D} = 2.0 A
Resistance *1	R _{DS(on)2}		43	62	mΩ	$V_{GS} = 2.5 \text{ V}, I_D = 2.0 \text{ A}$
Input Capacitance	C _{iss}		330		pF	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$
Output Capacitance	Coss		66		pF	f = 1.0 MHz
Reverse Transfer Capacitance	C _{rss}		38		pF	
Turn-on Delay Time	t _{d (on)}		12		ns	$I_D = 2.0 \text{ A}, V_{DD} = 10 \text{ V},$
Rise Time	t _r		6.4		ns	$V_{GS} = 4.5 \text{ V}, R_{G} = 6 \Omega$
Turn-off Delay Time	t _{d (off)}		27		ns	
Fall Time	t _f		6.6		ns	
Total Gate Charge	Q_G		4.5		nC	I _D = 4.0 A , V _{DD} = 16 V,
Gate to Source Charge	Q _{GS}		1.0		nC	V _{GS} = 10 V
Gate to Drain Charge	Q_{GD}		1.5		nC	
Body Diode Forward Voltage *1	V _{F(S-D)}			1.5	V	I _F = 4.0 A, V _{GS} = 0 V

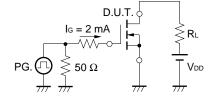
Note: *1. Pulsed

TEST CIRCUIT 1 SWITCHING TIME

D.U.T. PG. RG RG $\tau = 1 \mu s$ Duty Cycle $\leq 1\%$



TEST CIRCUIT 2 GATE CHARGE



P-channel MOSFET

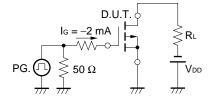
Characteristics	Symbol	MIN.	TYP.	MAX.	Unit	Test Conditions
Zero Gate Voltage Drain Current	I _{DSS}			-1.0	μA	V _{DS} = -20 V, V _{GS} = 0 V
Gate Leakage Current	I _{GSS}			∓10	μA	$V_{GS} = \mp 8 \text{ V}, V_{DS} = 0 \text{ V}$
Gate Cut-off Voltage	V _{GS(off)}	-0.4		-1.1	V	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$
Forward Transfer Admittance *1	y _{fs}	4.5			S	$V_{DS} = -5 \text{ V}, I_{D} = -2 \text{ A}$
Drain to Source On-state	R _{DS(on)1}		63	79	mΩ	$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}$
Resistance *1	R _{DS(on)2}		78	105	mΩ	$V_{GS} = -2.5 \text{ V}, I_D = -1.5 \text{ A}$
	R _{DS(on)3}		109	182	mΩ	$V_{GS} = -1.8 \text{ V}, I_D = -1.5 \text{ A}$
Input Capacitance	C _{iss}		473		pF	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$
Output Capacitance	C _{oss}		88		pF	f = 1.0 MHz
Reverse Transfer Capacitance	C _{rss}		68		pF	
Turn-on Delay Time	t _{d (on)}		11.5		ns	$I_D = -1.5 \text{ A}, V_{DD} = -10.0 \text{ V},$
Rise Time	t _r		4.0		ns	$V_{GS} = -4.0 \text{ V}, R_{G} = 6 \Omega$
Turn-off Delay Time	t _{d (off)}		37.5		ns	
Fall Time	t _f		12.5		ns	
Total Gate Charge	Q_G		5.1		nC	$I_D = -3.0 \text{ A}$, $V_{DD} = -16 \text{ V}$,
Gate to Source Charge	Q _{GS}		0.9		nC	V _{GS} = -4.5 V
Gate to Drain Charge	Q_{GD}		1.5		nC	
Body Diode Forward Voltage *1	V _{F(S-D)}			1.5	V	I _F = 3.0 A, V _{GS} = 0 V

Note: *1. Pulsed

TEST CIRCUIT 1 SWITCHING TIME

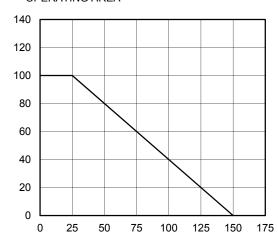
PG. \bigcap RG VDD VGS(-) 0 τ $\tau = 1 \,\mu s$ Duty Cycle $\leq 1\%$

TEST CIRCUIT 2 GATE CHARGE



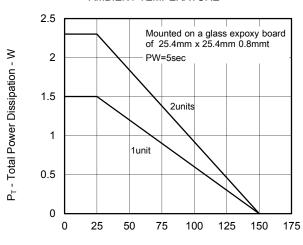
Typical Characteristics ($T_A = 25$ °C) N-channel MOSFET

DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



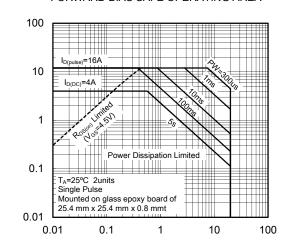
T_A -Ambient Temperature - °C

TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



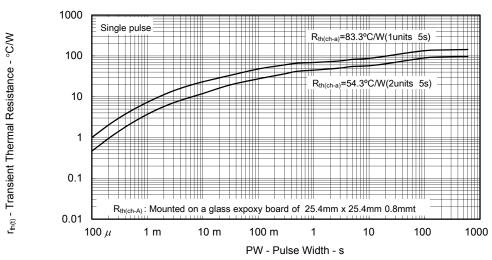
T_A -Ambient Temperature - °C

FORWARD BIAS SAFE OPERATING AREA



 $V_{\text{\scriptsize DS}}$ - Drain to Source Voltage - V

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



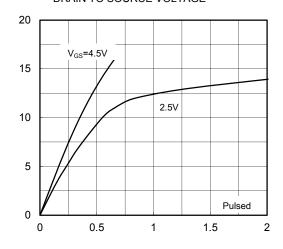
dT - Percentage of Rated Power - %

I_D -Drain Current - A

V_{GS(off)} – Gate to Source Cut-off Voltage - V

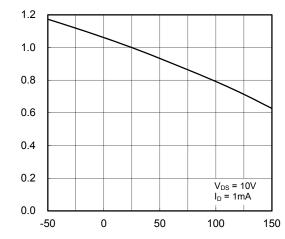
 $R_{\text{DS}(\text{on})}$ - Drain to Source On-state Resistance - $m\Omega$

DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



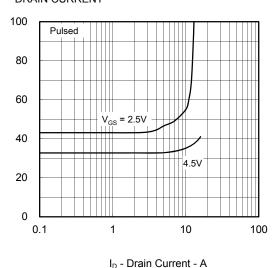
 V_{DS} - Drain to Source Voltage - V

GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

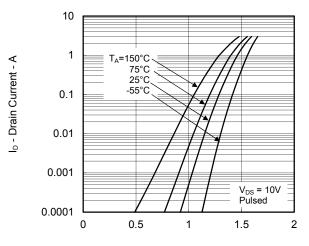


T_{ch} - Channel Temperature - °C

DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

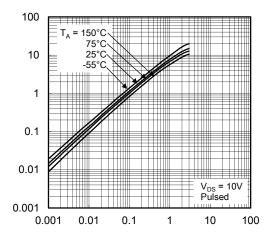


FORWARD TRANSFER CHARACTERISTICS



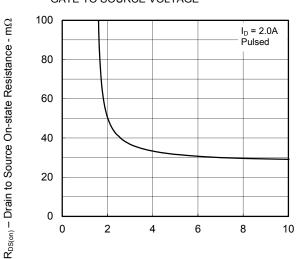
V_{GS} - Gate to Source Voltage - V

FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



I_D – Drain Current - A

DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



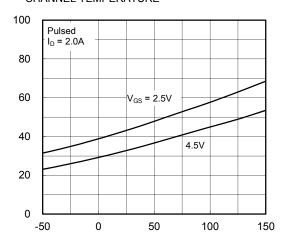
V_{GS} - Gate to Source Voltage - V

| y_{fs} | - Forward Transfer Admittance - S

 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}\operatorname{-Drain}$ to Source On-state Resistance - $m\Omega$

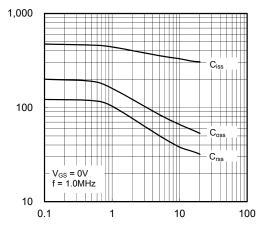
t_{d(on)}, t_f, t_{d(off)}, t_r - Switching Time - Ls

DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



T_{ch} - Channel Temperature - °C

CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

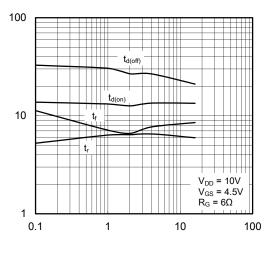


Ciss, Coss, Crss - Capacitance - pF

V_{DS} - Drain to Source Voltage - V

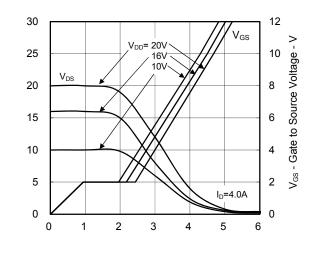
V_{DS} - Drain to Source Voltage - V

SWITCHING CHARACTERISTICS



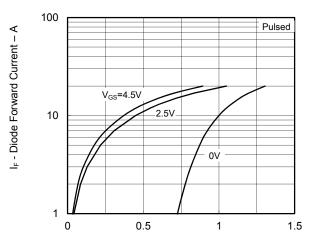
ID - Drain Current - A

DYNAMIC INPUT/OUTPUT CHARACTERISTICS



 $\ensuremath{\mathsf{Q}}_{\ensuremath{\mathsf{G}}}$ - Gate Charge - nC

SOURCE TO DRAIN DIODE FORWARD VOLTAGE

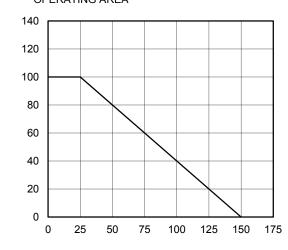


 $V_{F(S\!-\!D)}$ - Drain to Source Voltage - V

dT - Percentage of Rated Power - %

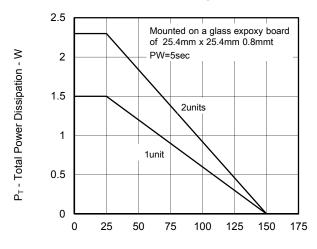
P-channel MOSFET

DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



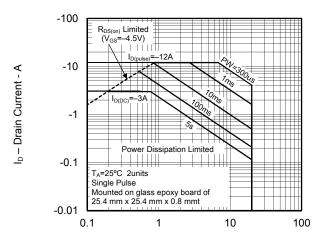
T_{A} -Ambient Temperature - $^{\circ}\text{C}$

TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



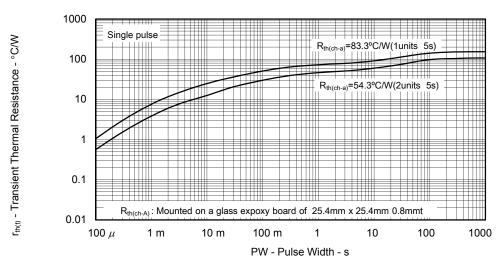
T_A -Ambient Temperature - °C

FORWARD BIAS SAFE OPERATING AREA



 $V_{\text{\scriptsize DS}}$ - Drain to Source Voltage - V

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

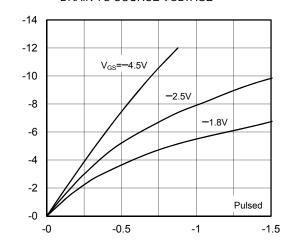


I_D -Drain Current - A

V_{GS(off)} – Gate to Source Cut-off Voltage - V

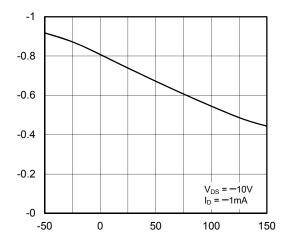
R_{DS(on)} - Drain to Source On-state Resistance - mΩ

DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



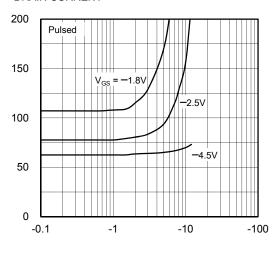
V_{DS} - Drain to Source Voltage - V

GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



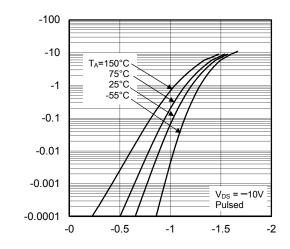
T_{ch} - Channel Temperature - °C

DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



ID - Drain Current - A

FORWARD TRANSFER CHARACTERISTICS



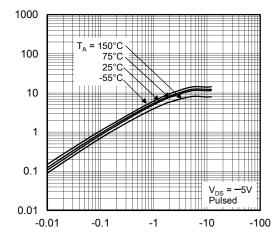
Ip - Drain Current - A

| y_{fs} | - Forward Transfer Admittance - S

 $R_{\text{DS(on)}}-\text{Drain}$ to Source On-state Resistance - $m\Omega$

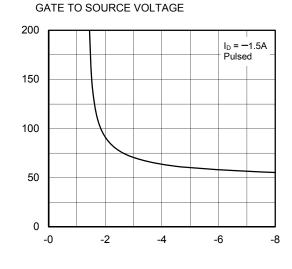
V_{GS} - Gate to Source Voltage - V

FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs.

I_D - Drain Current - A

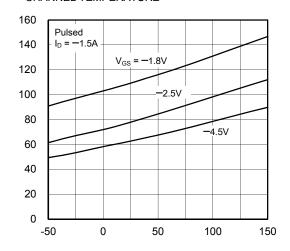


 V_{GS} - Gate to Source Voltage - V

R_{DS(on)} –Drain to Source On-state Resistance - mΩ

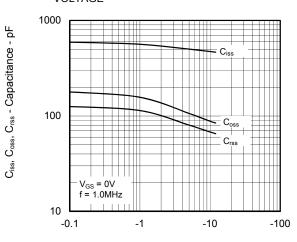
t_{d(on)}, t_f, t_{d(off)}, t_r - Switching Time - μ s

DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



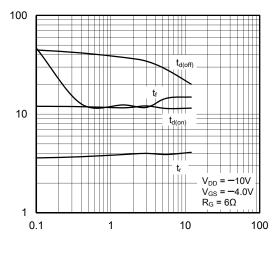
T_{ch} - Channel Temperature - °C

CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



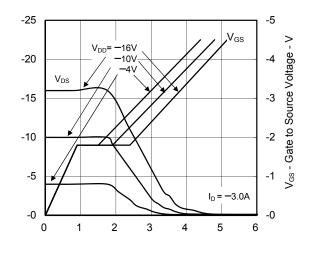
V_{DS} - Drain to Source Voltage - V

SWITCHING CHARACTERISTICS



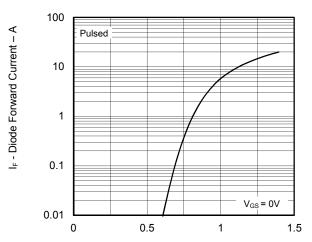
ID - Drain Current - A

DYNAMIC INPUT/OUTPUT CHARACTERISTICS



Q_G - Gate Charge - nC

SOURCE TO DRAIN DIODE FORWARD VOLTAGE

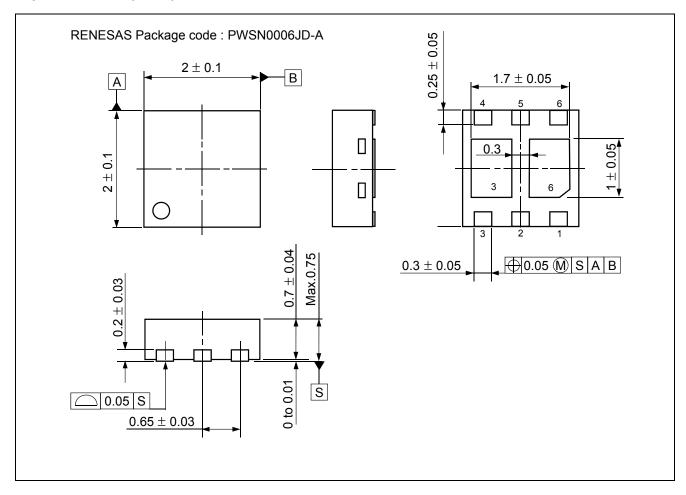


 $V_{F(S-D)}$ - Drain to Source Voltage - V

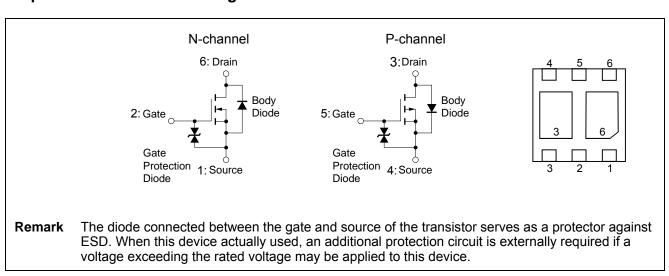
V_{DS} - Drain to Source Voltage - V

Package Drawings (Unit: mm)

6pinHUSON2020(DUAL)



Equivalent Circuit / Pin Assignment



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